SHIGA7.055APC PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Hirayama et al.

Appl. No. : 10/590,046

Filed : June 15, 2007

For: : BASE MATERIAL FOR

PATTERN-FORMING

MATERIAL, POSITIVE RESIST COMPOSITION AND METHOD

OF RESIST PATTERN

FORMATION

Examiner : Johnson, C.

Group Art Unit : 1795

AMENDMENT AND RESPONSE TO OFFICE ACTION

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In response to the Office Action mailed July 20, 2010, please consider the following remarks

The listing of claims begins on page 2 of this paper. No amendments have been made. **Remarks** begin on page 9 of this paper.